Product data sheet

1. Product profile

1.1 General description

The BF1215 is a combination of two dual gate MOSFET amplifiers with shared source lead, shared gate2 lead and an integrated switch.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor is available as a SOT363 micro-miniature plastic package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

- Two low noise gain controlled amplifiers in a single package; one with full internal bias and one with partial internal bias
- Superior cross modulation performance during AGC
- High forward transfer admittance to input capacitance ratio
- Suitable for VHF and UHF applications: both amplifiers are optimized for VHF applications.
- Internal switch reduces external components

1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with a 5 V supply
 - Digital and analog television tuners
 - Professional communication equipment



1.4 Quick reference data

Table 1.	Quick reference data for a	mplifier A and B					
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	DC		-	-	6	V
I _D	drain current	DC		-	-	30	mA
P _{tot}	total power dissipation	$T_{sp} \le 107 \ ^{\circ}C$	[1]	-	-	180	mW
y _{fs}	forward transfer admittance	$ f = 100 \text{ MHz}; \text{T}_{\text{j}} = 25 \ ^{\circ}\text{C}; I_{\text{D}} = 19 \text{ mA} $		23	27	38	mS
$C_{iss(G1)}$	input capacitance at gate1	f = 100 MHz	[2]	-	2.5	-	pF
C _{rss}	reverse transfer capacitance	f = 100 MHz	[2]	-	27	-	fF
NF	noise figure	$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.5	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.9	-	dB
Xmod	cross modulation	input level for k = 1 % at 40 dB AGC; f_w = 50 MHz; f_{unw} = 60 MHz	<u>[3]</u>	105	107	-	dBμV
Tj	junction temperature			-	-	150	°C

 $\label{eq:tau} [1] \quad T_{sp} \mbox{ is the temperature at the soldering point of the source lead.}$

[2] Calculated from S-parameters.

[3] Measured in Figure 32 and Figure 33 test circuits.

2. Pinning information

Table 2.	Discrete pinning		
Pin	Description	Simplified outline	Graphic symbol
1	gate1 (amplifier A)		
2	gate2		AMP a
3	gate1 (amplifier B)		G1 (A) (A)
4	drain (amplifier B)		
5	source	1 2 3	G2++++s
6	drain (amplifier A)		

sym033

AMP b

G1 (B) D

3. Ordering information

Table 3. Ordering information

Type number	Package						
	Name	Description	Version				
BF1215	-	plastic surface-mounted package; 6 leads	SOT363				

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4. Marking

Table 4. Marking							
Type number Marking Description							
BF1215	M4p	made in Hong Kong					
	M4t	made in Malaysia					
	M4w	made in China					

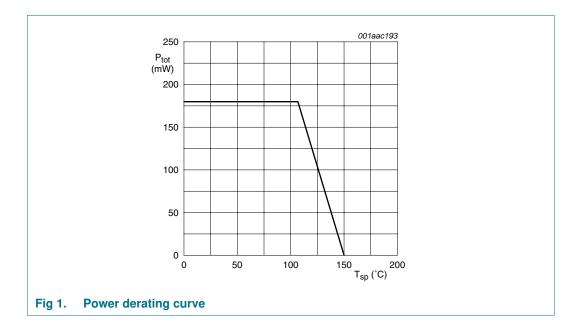
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per MOSFE	T				
V _{DS}	drain-source voltage	DC	-	6	V
I _D	drain current	DC	-	30	mA
I _{G1}	gate1 current		-	±10	mA
I _{G2}	gate2 current		-	±10	mA
P _{tot}	total power dissipation	$T_{sp} \le 107 \ ^{\circ}C$	<u>1]</u> -	180	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

[1] T_{sp} is the temperature at the soldering point of the source lead.



6. Thermal characteristics

Table 6.	Thermal characteristics							
Symbol	Parameter	Conditions	Тур	Unit				
R _{th(j-sp)}	thermal resistance from junction to solder point		240	K/W				

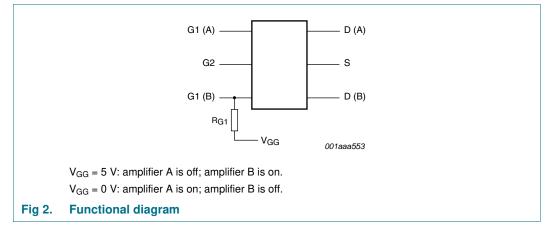
7. Static characteristics

Table 7.Static characteristicsT25 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per MOSFE	ET; unless otherwise specified					
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0 V; I_D = 10 \ \mu A$				
		amplifier A	6	-	-	V
		amplifier B	6	-	-	V
V _{(BR)G1-SS}	gate1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0 V; I_{G1-S} = 10 mA$	6	-	10	V
V _{(BR)G2-SS}	gate2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0 V; I_{G2-S} = 10 mA$	6	-	10	V
V _{F(S-G1)}	forward source-gate1 voltage	$V_{G2-S} = V_{DS} = 0 V; I_{S-G1} = 10 mA$	0.5	-	1.5	V
V _{F(S-G2)}	forward source-gate2 voltage	$V_{G1-S} = V_{DS} = 0 V; I_{S-G2} = 10 mA$	0.5	-	1.5	V
V _{G1-S(th)}	gate1-source threshold voltage	V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 100 μ A	0.3	-	1.0	V
V _{G2-S(th)}	gate2-source threshold voltage	V_{DS} = 5 V; V_{G1-S} = 5 V; I_D = 100 μ A	0.4	-	1.0	V
I _{DS}	drain-source current	$V_{G2\text{-}S} = 4 \text{ V}; V_{DS(B)} = 5 \text{V}; \text{R}_{G1} = 39 \text{k} \Omega$				
		amplifier A: $V_{DS(A)} = 5 V$	<u>[1]</u> -	-	19.5	mA
		amplifier B	[2] _	-	23	mA
I _{G1-S}	gate1 cut-off current	$V_{G2-S} = 0 V; V_{DS(A)} = V_{DS(B)} = 0 V$				
		amplifier A: $V_{G1-S(A)} = 5 V$	-	-	50	nA
		amplifier B: $V_{G1-S(B)} = 5 V$	-	-	50	nA
I _{G2-S}	gate2 cut-off current	$V_{G2-S} = 4 V; V_{DS(A)} = V_{DS(B)} = 0 V; V_{G1-S(A)} = V_{G1-S(B)} = 0 V$	-	-	20	nA

[1] R_{G1} connects gate1 amplifier B to $V_{GG} = 0$ V, see Figure 2.

[2] R_{G1} connects gate1 amplifier B to $V_{GG} = 5$ V, see Figure 2.



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8. Dynamic characteristics

Table 8. Dynamic characteristics for amplifier A and B

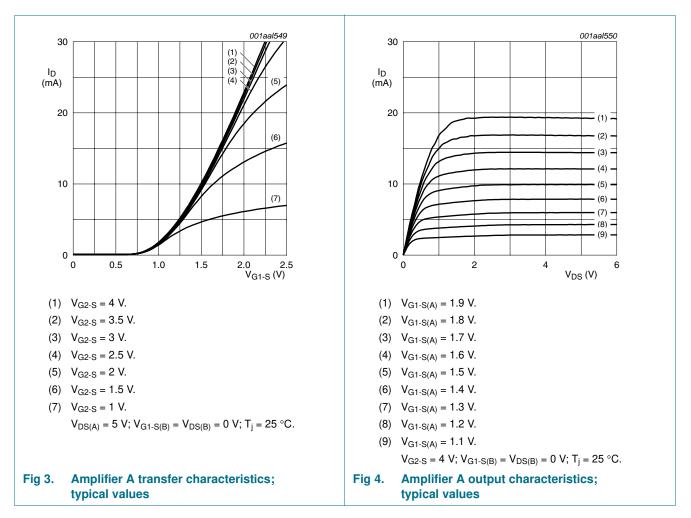
Common source; $T_{amb} = 25 \text{ °C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 19 \text{ mA}$.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
y _{fs}	forward transfer admittance	f = 100 MHz; T _j = 25 °C		23	27	38	mS
C _{iss(G1)}	input capacitance at gate1	f = 100 MHz	[1]	-	2.5	-	pF
C _{iss(G2)}	input capacitance at gate2	f = 100 MHz	[1]	-	2.5	-	pF
C _{oss}	output capacitance	f = 100 MHz	[1]	-	0.8	-	pF
C _{rss}	reverse transfer capacitance	f = 100 MHz	[1]	-	27	-	fF
G _{tr}	transducer power gain	amplifier A: $B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$	[1]				
		$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 0.5 \text{ mS}$		30	34	38	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 1 \text{ mS}$		26	30	34	dB
		$f = 800 \text{ MHz}; G_S = 3.3 \text{ mS}; G_L = 1 \text{ mS}$		22	26	30	dB
		amplifier B: $B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$	[1]				
		$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 0.5 \text{ mS}$		30	34	38	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 1 \text{ mS}$		26	31	34	dB
		$f = 800 \text{ MHz}; G_S = 3.3 \text{ mS}; G_L = 1 \text{ mS}$		22	26	30	dB
NF	noise figure	$f = 11 \text{ MHz}; G_S = 20 \text{ mS}; B_S = 0 \text{ S}$		-	-	6	dB
		$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.5	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.9	-	dB
Xmod cross modulation		input level for k = 1 %; f _w = 50 MHz; f _{unw} = 60 MHz	[2]				
		at 0 dB AGC		95	104	-	dBµ∖
		at 10 dB AGC		-	100	-	dBµ∖
		at 20 dB AGC		-	104	-	dBµ∖
		at 40 dB AGC		105	107	-	dBµ∖

[1] Calculated from S-parameters.

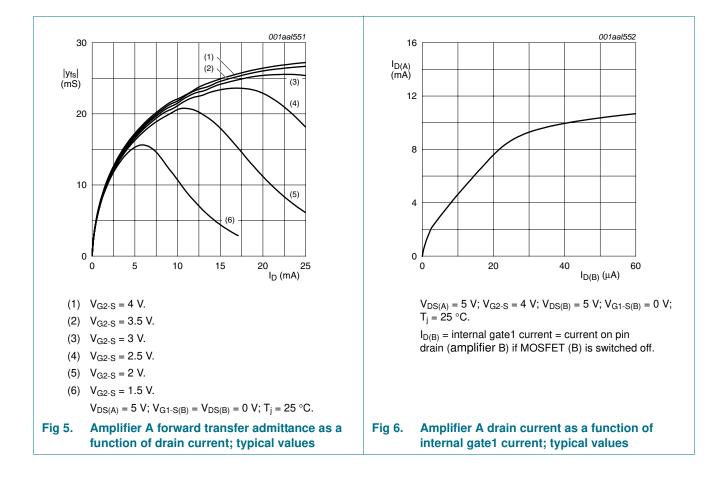
[2] Measured in Figure 32 and Figure 33 test circuits.

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8.1 Graphics for amplifier A

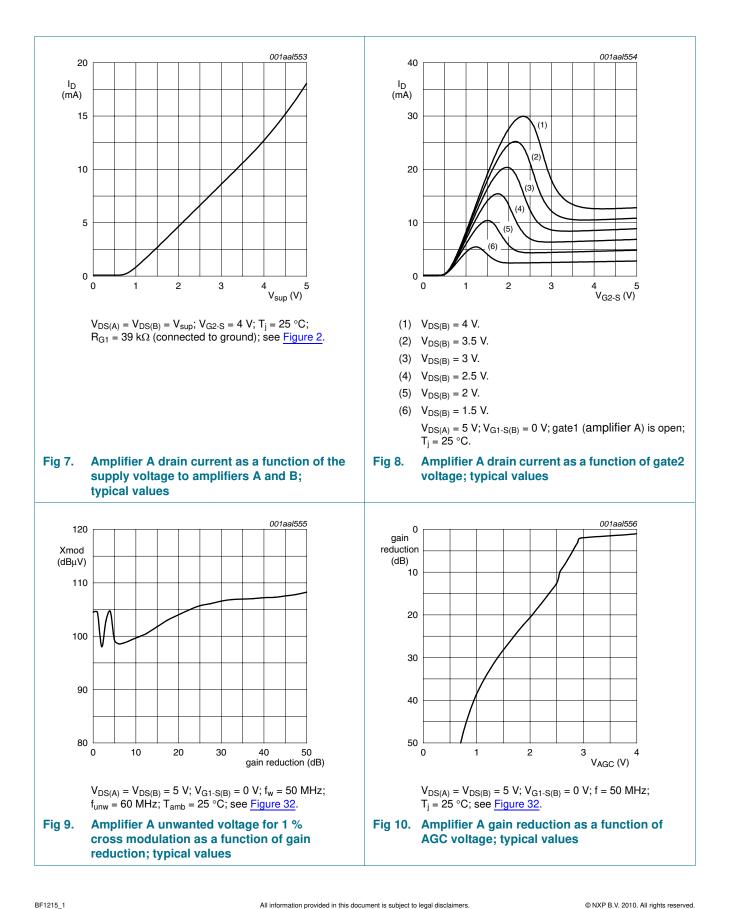
Dual N-channel dual gate MOSFET



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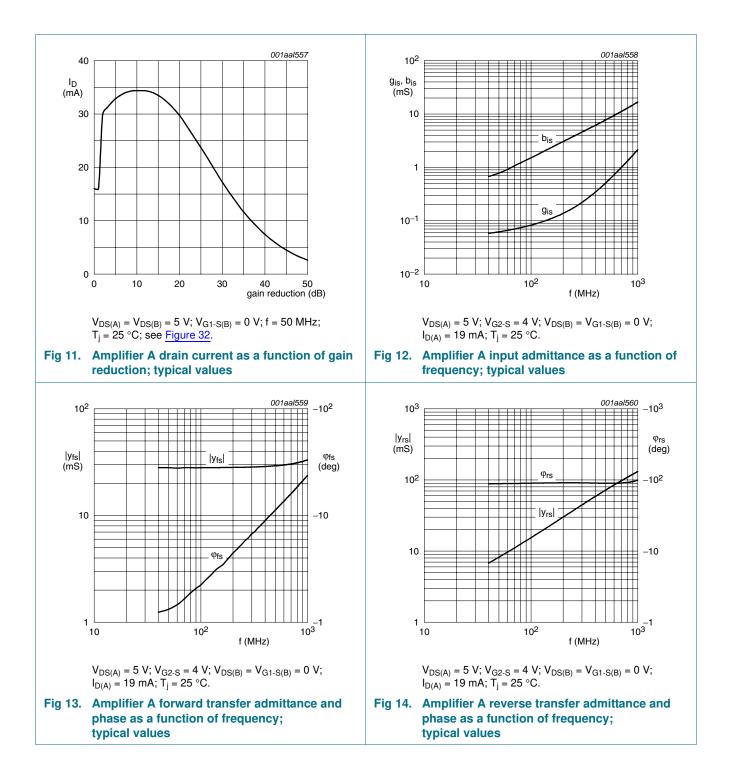
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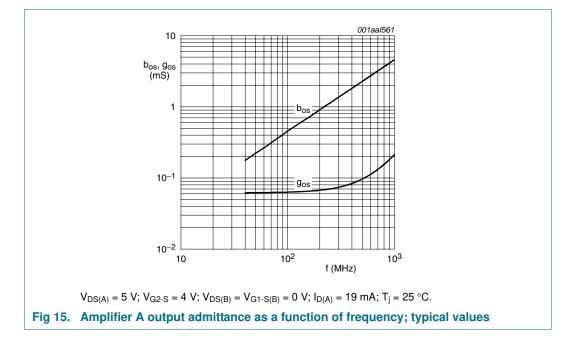


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8.2 Scattering parameters for amplifier A

Table 9. Scattering parameters for amplifier A

 $V_{DS(A)} = 5 V$; $V_{G2-S} = 4 V$; $I_{D(A)} = 19 mA$; $V_{DS(B)} = 0 V$; $V_{G1-S(B)} = 0 V$; $T_{amb} = 25 °C$; typical values.

f (MHz)	s ₁₁	s ₁₁			s ₁₂		S ₂₂	
	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)
50	0.992	-4.61	2.80	175.87	0.00078	95.65	0.993	-1.38
100	0.991	-8.79	2.80	172.12	0.00145	83.73	0.994	-2.76
200	0.986	-17.57	2.77	164.25	0.00292	78.53	0.992	-5.50
300	0.977	-26.11	2.74	156.52	0.00415	73.60	0.991	-8.21
400	0.966	-34.46	2.69	148.98	0.00528	69.27	0.989	-10.91
500	0.952	-42.75	2.64	141.49	0.00620	64.79	0.986	-13.58
600	0.936	-50.92	2.58	134.13	0.00691	60.71	0.984	-16.22
700	0.920	-58.79	2.50	127.01	0.00733	57.37	0.982	-18.86
800	0.902	-66.40	2.43	120.04	0.00758	54.40	0.979	-21.47
900	0.881	-73.87	2.36	113.24	0.00763	52.13	0.978	-24.00
1000	0.861	-81.10	2.28	106.69	0.00749	50.46	0.976	-26.55

8.3 Noise data for amplifier A

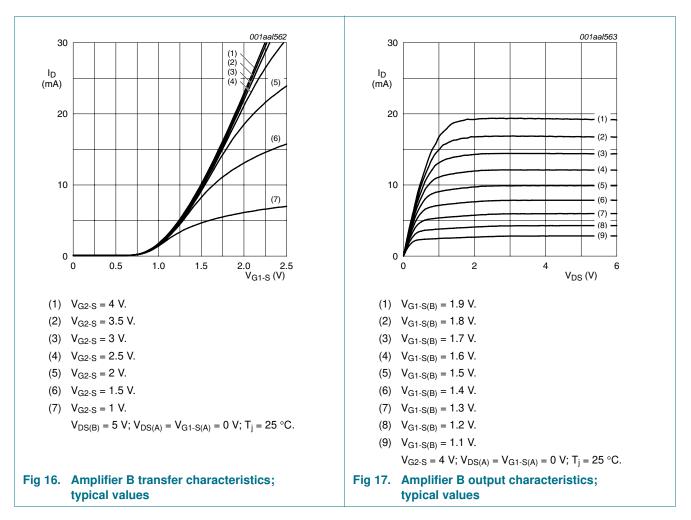
Table 10. Noise data for amplifier A

 $V_{DS(A)} = 5 V$; $V_{G2-S} = 4 V$; $I_{D(A)} = 19 mA$; $V_{DS(B)} = 0 V$; $V_{G1-S(B)} = 0 V$; $T_{amb} = 25 °C$; typical values; unless otherwise specified.

f (MHz)	NF _{min} (dB)	Γ_{opt}	Γ _{opt}		
		(ratio)	(degree)		
400	0.9	0.810	27.95	0.884	
800	1.4	0.697	56.50	0.717	

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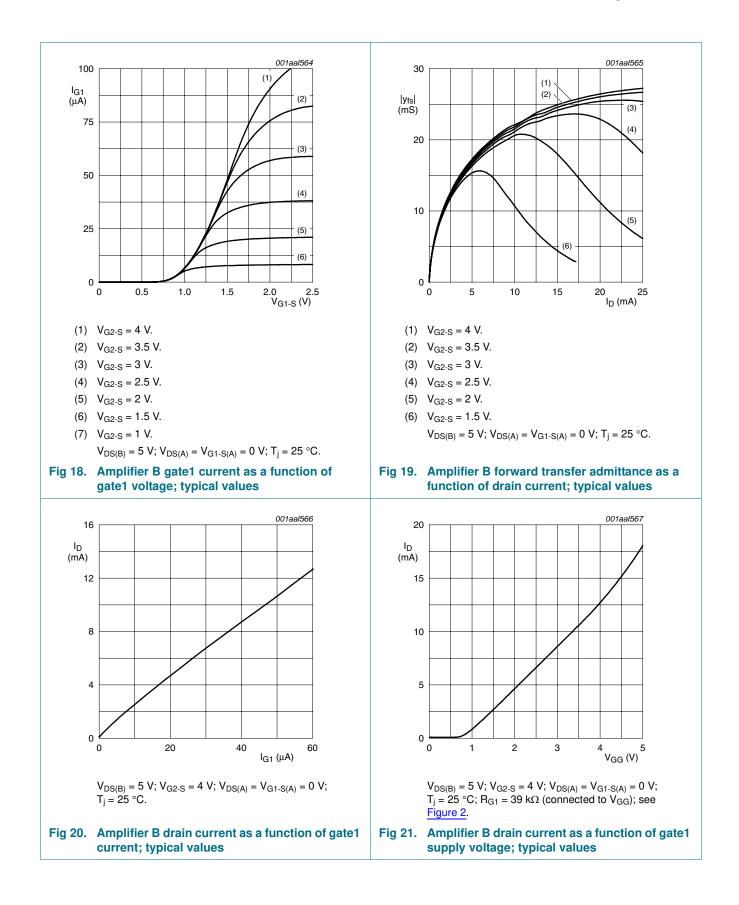


8.4 Graphics for amplifier B

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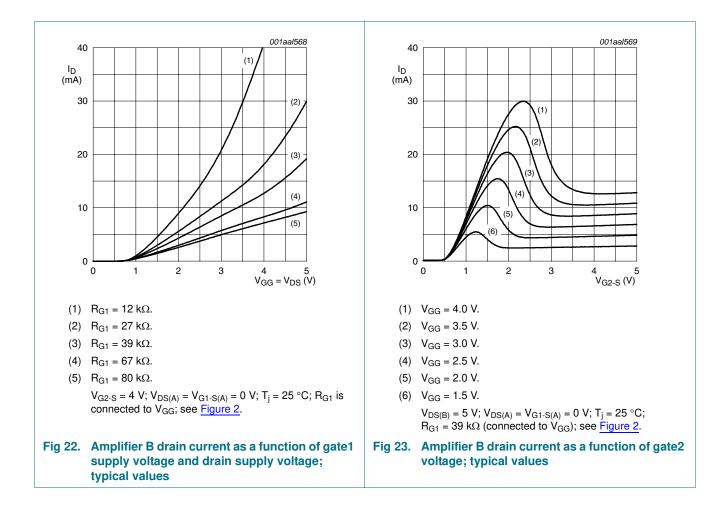
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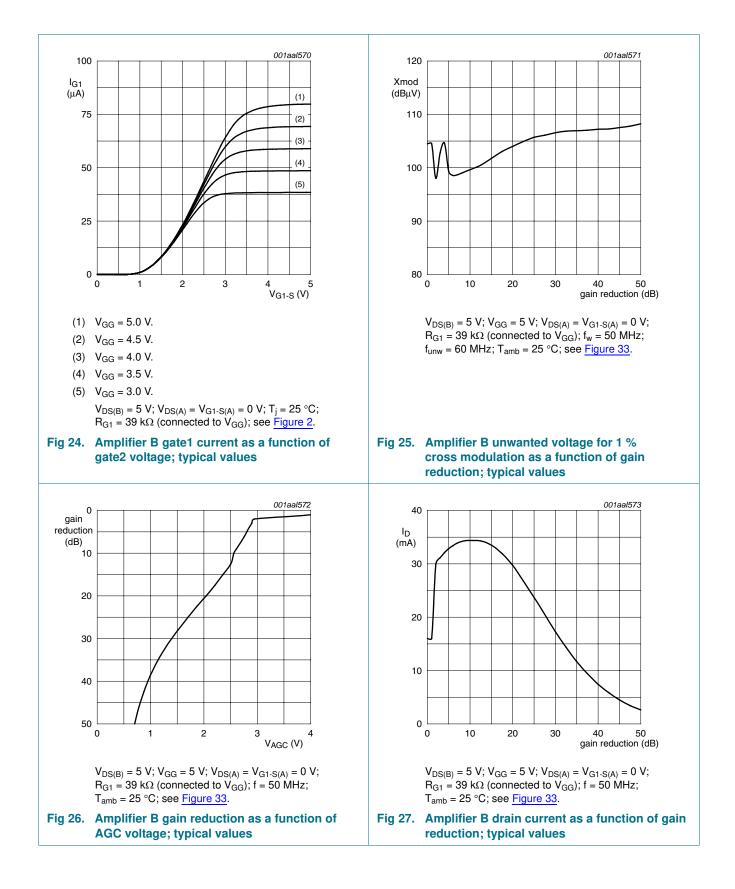
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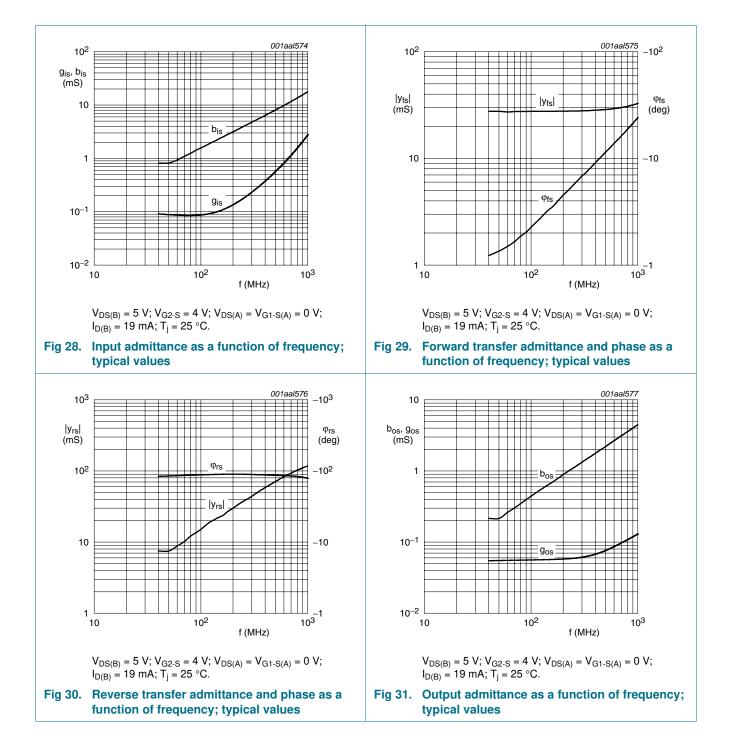
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Dual N-channel dual gate MOSFET



Dual N-channel dual gate MOSFET



8.5 Scattering parameters for amplifier B

Table 11. Scattering parameters for amplifier B

 $V_{DS(B)} = 5 V$; $V_{G2-S} = 4 V$; $I_{D(B)} = 15 mA$; $V_{DS(A)} = 0 V$; $V_{G1-S(A)} = 0 V$; $T_{amb} = 25 °C$; typical values.

f (MHz)	S ₁₁		s ₂₁	s ₂₁		s ₁₂		s ₂₂	
	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	
50	0.987	-4.68	2.77	175.73	0.00074	100.59	0.992	-1.47	
100	0.983	-8.74	2.75	171.97	0.00147	85.47	0.992	-3.03	
200	0.979	-17.33	2.73	164.04	0.00291	83.85	0.991	-6.07	
300	0.970	-25.74	2.70	156.20	0.00422	82.04	0.989	-9.06	
400	0.961	-33.99	2.66	148.55	0.00547	80.56	0.987	-12.03	
500	0.948	-42.21	2.60	140.92	0.00654	79.15	0.986	-14.99	
600	0.932	-50.29	2.54	133.41	0.00744	78.33	0.983	-17.97	
700	0.917	-58.13	2.47	126.14	0.00822	78.46	0.981	-20.93	
800	0.900	-65.75	2.40	119.00	0.00890	78.92	0.978	-23.84	
900	0.981	-73.19	2.33	112.02	0.00947	80.11	0.977	-26.71	
1000	0.962	-80.36	2.25	105.26	0.00997	81.84	0.975	-29.63	

8.6 Noise data for amplifier B

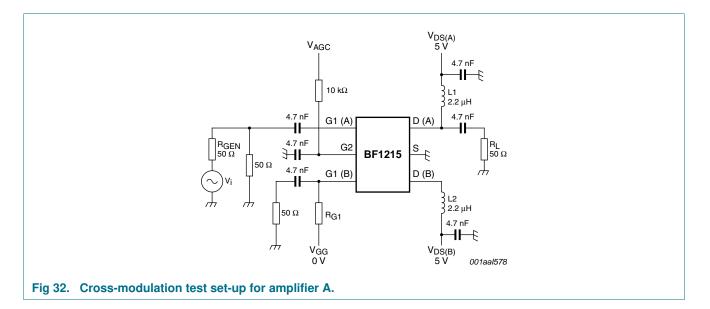
Table 12. Noise data for amplifier B

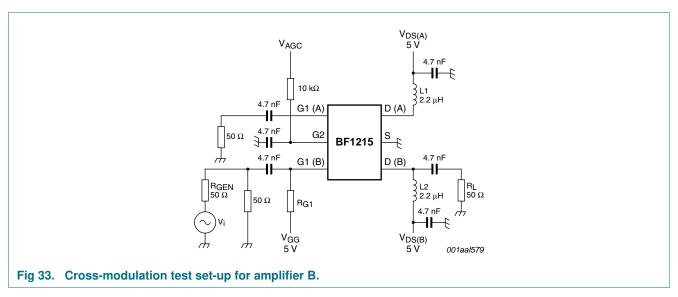
 $V_{DS(B)} = 5 V$; $V_{G2-S} = 4 V$; $I_{D(B)} = 19 mA$; $V_{DS(A)} = 0 V$; $V_{G1-S(A)} = 0 V$; $T_{amb} = 25 °C$; typical values; unless otherwise specified.

f (MHz)	NF _{min} (dB)	Γ _{opt}	r _n (Ω)	
		(ratio)	(deg)	
400	1.1	0.755	27.61	0.860
800	1.6	0.659	56.19	0.712

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9. Test information





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10. Package outline

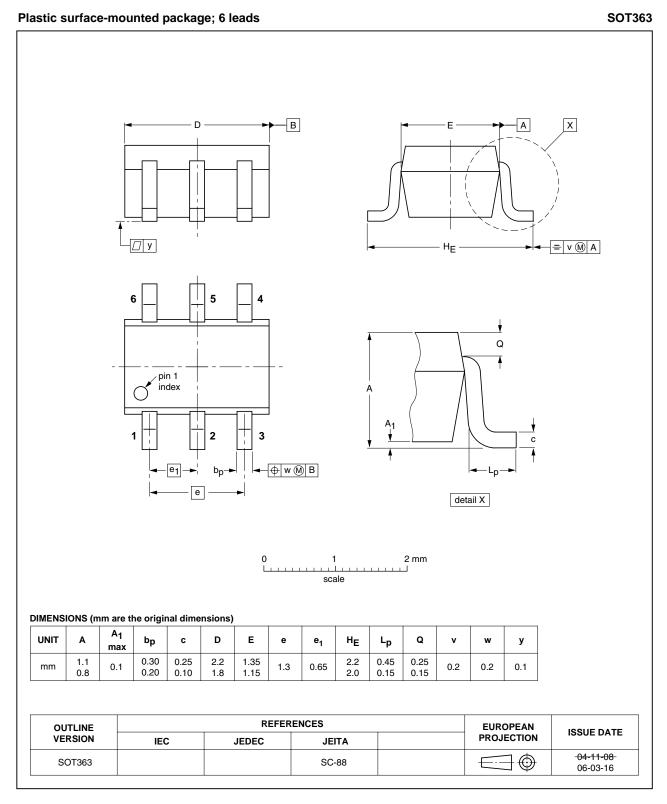


Fig 34. Package outline SOT363

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11. Abbreviations

Table 13. Abbreviations				
Acronym	Description			
AGC	Automatic Gain Control			
DC	Direct Current			
MOSFET	Metal-Oxide-Semiconductor Field-Effect Transistor			
UHF	Ultra High Frequency			
VHF	Very High Frequency			

12. Revision history

Table 14. Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes		
BF1215_1	20100506	Product data sheet	-	-		

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[1] Please consult the most recently issued document before initiating or completing a design.

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14. Contact information

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